

Search Notes

Application/Control No.

10/535,171

Examiner

Huyen Le

Applicant(s)/Patent under
Reexamination

FUKUI ET AL.

Art Unit

3751

SEARCHED

Class	Subclass	Date	Examiner
401	107--109	9/17/2007	HL
	updated		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
US-PGPUB		9/17/2007	HL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR